

**Search Notes**

Application/Control No.

10/658,158

Examiner

Tan T. Nguyen

Applicant(s)/Patent under  
Reexamination

TRAN ET AL.

Art Unit

2827

**SEARCHED**

Class	Subclass	Date	Examiner
365	173	3/30/2005	TNT
365	171	3/30/2005	TNT
365	157	3/30/2005	TNT
365	158	3/30/2005	TNT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
365	157	3/30/2005	TNT
365	158	3/30/2005	TNT
365	171	3/30/2005	TNT
365/173		3/30/2005	TNT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR